Notice of References Cited Application/Control No. 10/510,343 Examiner Mark Kopec Applicant(s)/Patent Under Reexamination TAKAMURA ET AL. Page 1 of 1

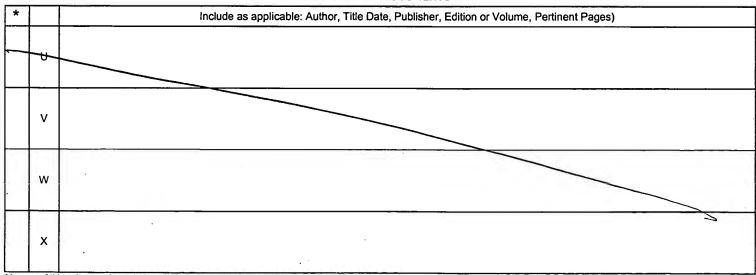
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0027033	02-2003	Seabaugh et al.	429/40
/	В/	US-			
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	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			·
	J	US-			
	K	US-			
	L	US-			
П	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 2005053763	03-2005	JP (Eng. Ab.)		
	0	JP 2005281086	10-2005	JP (Eng. Ab.)		
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	T				4 (2.00)	

NON-PATENT DOCUMENTS



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